Docket No.: 043888-0267

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 20277

Tsutomu OHZUKU, et al.

Confirmation Number: 9492

Application No.: 10/629,815

Group Art Unit: 1745

Filed: July 30, 2003

Examiner: LEE, CYNTHIA K

For: POSITIVE ELECTRODE ACTIVE MATERIAL AND NON-AQUEOUS ELECTROLYTE

SECONDARY BATTERY CONTAINING THE SAME

INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed more than three months after the U.S. filing date AND after the mailing date of the first Office Action on the merits, but before the mailing date of a Final Rejection or Notice of Allowance.

> 05/02/2007 DEMMANU1 00000074 590417 10629815

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10/629,815

In accordance with 37 CFR 1.17(p), please charge the fee of \$180.00 to Deposit Account

No. 500417.

The references were cited in corresponding Japanese and Korean Office Actions and their

relevance is discussed therein. Copies of the Japanese and Korean Office Actions are attached

for the Examiner's information.

Please charge any shortage in fees due in connection with the filing of this paper,

including extension of time fees, to Deposit Account 500417 and please credit any excess fees to

such deposit account.

Respectfully submitted,

McDERMOTT WILL & EMERY LLP

Please recognize our Customer No. 20277

as our correspondence address.

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Date: May 1, 2007

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SHEET <u>1</u> OF <u>3</u>

ATTY. DOCKET NO. CITATION IN AN APPLICATION APPLICANT Tsutomu OHZUKU, et al.

(PTO-1449)

FILING DATE GROUP
July 30, 2003 1745

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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			APPLICANT Tsutomu OHZUKU, et al.						
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